

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/702,038	KATOU ET AL.	
Examiner		Art Unit		Page 1 of 1
CHRISTOPHER BOSWELL		3673		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,118,055 A	10-1978	Bischoff, Jr., Robert F.	292/165
*	B	US-5,149,152 A	09-1992	Lanius, Charles A.	292/37
*	C	US-5,342,101 A	08-1994	Shih, Nan C.	292/165
*	D	US-6,350,418 B1	02-2002	Venderpool et al.	292/37
*	E	US-6,460,902 B1	10-2002	Kyle, James H.	292/165
*	F	US-6,622,883 B1	09-2003	Wu et al.	292/36
*	G	US-6,733,049 B2	05-2004	Piorkowski et al.	292/139
*	H	US-2004/0256863 A1	12-2004	Tsai, Miao Hsueh	292/165
*	I	US-6,834,895 B2	12-2004	Lin, Wei-Hsin	292/34
*	J	US-7,048,311 B2	05-2006	Sawatani et al.	292/33
*	K	US-2007/0163310 A1	07-2007	Ookawara et al.	292/032
*	L	US-7,455,333 B2	11-2008	Ookawara, Toshihiko	292/34
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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